

FORM PTO-1449 (Modified)
U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(Use several sheets if necessary)

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Serial No.: 10/823,257

Applicant(s): Quintero Illera et al.

Filing Date: April 13, 2004

Group: Not Yet Assigned 282.1

U.S. PATENT DOCUMENTS

Exam. Init.		Patent Number							Issue Date	Patentee	Class	Subclass	Filing Date
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		4	6	2	3	8	9	4	11/18/1986	Lee et al.			
		4	6	7	3	9	4	8	06/16/1987	Kuo			
		4	7	3	0	1	9	5	03/08/1988	Phillips et al.			
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	5	2	5	5	0	0	10/19/1993	Day
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	5	3	5	5	1	4	10/11/1994	Walton et al.
	5	3	5	5	3	1	10/11/1994	Dionnet et al.
	5	3	7	3	3	0	12/13/1994	Jenness et al.
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	5	4	2	0	5	9	05/30/1995	Brkocovic
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	5	4	5	1	9	6	09/19/1995	Emery
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TP	0	0	9	6	8	4	12/28/1983	EP			X (English Abstract)
	0	2	9	7	8	1	06/24/1988	EP			
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Examiner	THO PHAN
Date Considered 6/30/06	
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



Substitute for form 1449/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Application Number	10/823257-Conf. #3496
		Filing Date	April 13, 2004
		First Named Inventor	Ramiro Quintero Illera
		Art Unit	2821
		Examiner Name	T. G. Phan
Sheet 1 of 1	Attorney Docket Number	68349-00011USPX	

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Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number-Kind Code ² (if known)		
TP ↓	A1*	US-6,545,640	04-08-2003	Herve et al.
	A2*	US-6,606,062-A1	08-12-2003	Ngounou Kouam et al.
	A3*	US-6,664,932-A1	12-16-2003	Sabet et al.
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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			
TP	B1	EP-1128466	08-29-2001	Filtronic LK Oy	
↓	B2	WO-02/095874	11-28-2002	Raytheon Company	

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Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ²
TP	C1	"Small Cicularatory Polarized Microstrip Antennas" by Wen-Shyang Chen, Department of Electronic Engineering, Cheng-Shiu Institute of Technology, 1999 IEEE.			

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